

1200V, 50A, $V_{ce(on)} = 2.5V$ Typical

Ultra Fast NPT - IGBT®

The Ultra Fast NPT - IGBT® family of products is the newest generation of planar IGBTs optimized for outstanding ruggedness and the best trade-off between conduction and switching losses.

Features

- Low Saturation Voltage
- Low Tail Current
- RoHS Compliant

- Short Circuit Withstand Rated
- High Frequency Switching
- Ultra Low Leakage Current

Unless stated otherwise, Microsemi discrete IGBTs contain a single IGBT die. This device is recommended for applications such as induction heating (IH), motor control, general purpose inverters and uninterruptible power supplies (UPS).



MAXIMUM RATINGS

All Ratings: T_C = 25°C unless otherwise specified.

Symbol	Parameter	Ratings	Unit	
V _{ces}	Collector Emitter Voltage	1200	V	
$V_{\rm GE}$	Gate-Emitter Voltage	±30	V	
I _{C1}	Continuous Collector Current @ T _c = 25°C	117		
I _{C2}	Continuous Collector Current @ T _C = 110°C	50	Α	
I _{CM}	Pulsed Collector Current ①	200		
SCWT	Short Circuit Withstand Time: $V_{CE} = 600V$, $V_{GE} = 15V$, $T_{C} = 125^{\circ}C$	10	μs	
P _D	Total Power Dissipation @ T _c = 25°C	694	W	
T _J ,T _{STG}	Operating and Storage Junction Temperature Range	-55 to 150		
T_{\scriptscriptstyleL}	Max. Lead Temp. for Soldering: 0.063" from Case for 10 Sec.	300	°C	

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Parameter	Min	Тур	Max	Unit
V _{(BR)CES}	Collector-Emitter Breakdown Voltage $(V_{GE} = 0V, I_{C} = 1.0 \text{mA})$	1200			
V _{GE(TH)}	Gate Threshold Voltage $(V_{CE} = V_{GE}, I_{C} = 2.5 \text{mA}, T_{j} = 25 ^{\circ}\text{C})$	3.5	5.0	6.5	\ /-I4-
V _{CE(ON)}	Collector-Emitter On Voltage (V_{GE} = 15V, I_{C} = 50A, T_{j} = 25°C)		2.5	3.2	Volts
	Collector-Emitter On Voltage ($V_{GE} = 15V$, $I_{C} = 50A$, $T_{j} = 125^{\circ}C$)		3.3		
	Collector-Emitter On Voltage ($V_{GE} = 15V$, $I_{C} = 100A$, $T_{j} = 25^{\circ}C$)		3.5		
I _{CES}	Collector Cut-off Current (V _{CE} = 1200V, V _{GE} = 0V, T _j = 25°C) ②		10	1000	μA
	Collector Cut-off Current (V _{CE} = 1200V, V _{GE} = 0V, T _j = 125°C) ②		100		
I _{GES}	Gate-Emitter Leakage Current (V _{GE} = ±20V)			±250	nA

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
C _{ies}	Input Capacitance	Capacitance		5550		
C _{oes}	Output Capacitance	$V_{GE} = 0V, V_{CE} = 25V$		500		pF
C _{res}	Reverse Transfer Capacitance	f = 1MHz		145		
V_{GEP}	Gate to Emitter Plateau Voltage	Cata Charas		7.5		V
Q ₃	Total Gate Charge	Gate Charge		330	445	
Q_{ge}	Gate-Emitter Charge	V _{GE} = 15V		52	72	0
Q_{gc}	Gate- Collector Charge	V _{CE} = 600V I _C = 50A		156	200	nC
t _{d(on)}	Turn-On Delay Time	Inductive Switching (25°C)		28		
t _r	Current Rise Time	V _{cc} = 600V		38		
t _{d(off)}	Turn-Off Delay Time	V _{GE} = 15V		237		ns
t,	Current Fall Time	I _C = 50A		45		[
E _{on2} 5	Turn-On Switching Energy	$R_{_{\rm G}} = 4.3 \Omega^{(4)}$ $T_{_{\rm J}} = +25^{\circ}{\rm C}$		2135	3200	μJ
E _{off}	Turn-Off Switching Energy			1478	2210	
t _{d(on)}	Turn-On Delay Time	Inductive Switching (125°C)		28		
t _r	Current Rise Time	V _{cc} = 600V		38		
t _{d(off)}	Turn-Off Delay Time	V _{GE} = 15V		270		ns
t _f	Current Fall Time			54		
E _{on2}	Turn-On Switching Energy	$R_{_{\rm G}} = 4.3 \Omega^{(4)}$		3157	4765	1
E _{off}	Turn-Off Switching Energy	T _J = +125°C		1884	2820	μJ

THERMAL AND MECHANICAL CHARACTERISTICS

Symbol	Characteristic		Min	Тур	Max	Unit
$R_{\theta JC}$	Junction to Case Thermal Resistance (IGBT)				.18	°C/W
$R_{\theta JA}$	Junction to Ambient Thermal Resistance				40	C/VV
	Package Weight	B2		.22		oz
W _T				6		g
		L		.36		oz
				10		g

- 1 Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- 2 Pulse test: Pulse Width < $380\mu s$, duty cycle < 2%.
- 3 See Mil-Std-750 Method 3471.
- 4 $R_{\rm g}$ is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)
- 5 E_{on2} is the clamped inductive turn on energy that includes a commutating diode reverse recovery current in the IGBT turn on energy loss. A combi device is used for the clamping diode.
- 6 E_{off} is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1.

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

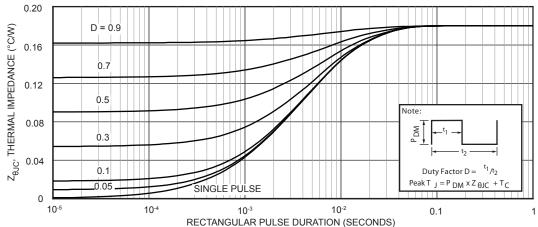
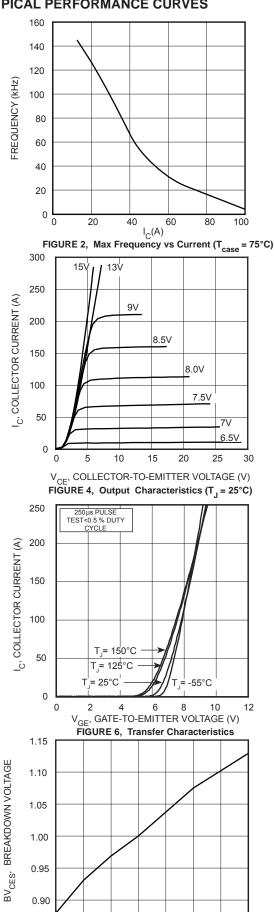


Figure 1, Maximum Effective Transient Thermal Impedance, Junction-To-Case vs Pulse Duration

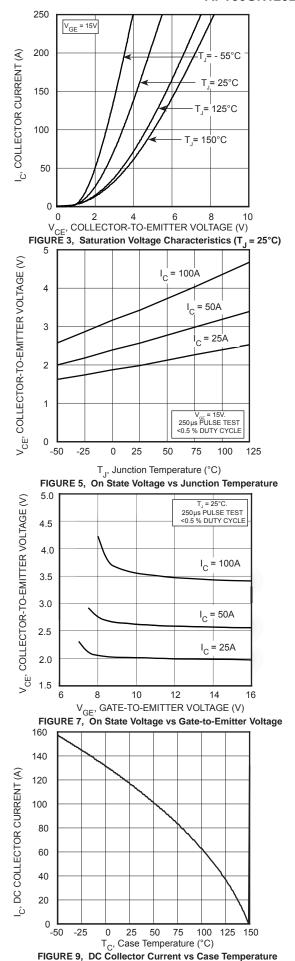


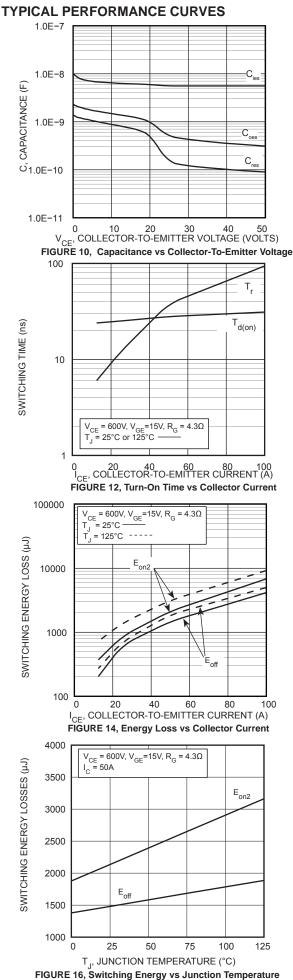
0.85

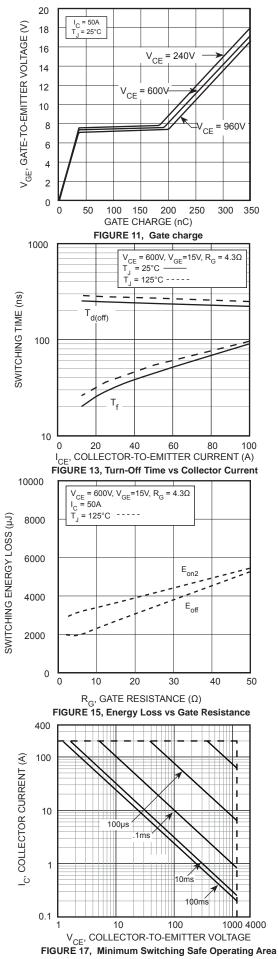
-50 -25 100

T_{.,}, JUNCTION TEMPERATURE

FIGURE 8, Breakdown Voltage vs Junction Temperature



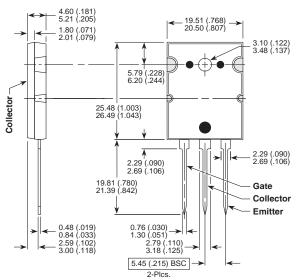




T-MAX™ (B2) Package Outline

These dimensions are equal to the TO-247 without the mounting hole. Dimensions in Millimeters and (Inches)

TO-264 (L) Package Outline



Dimensions in Millimeters and (Inches)

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